Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/750,466	LEE ET AL.	
Examiner	Art Unit	
Nyeemah Grazier	1626	

SEARCHED			
Class	Subclass	Date	Examiner
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		407-2-	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
544	153	11/2/2005	NG
	<u> </u>		
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
STIC	7/25/2005	NG.
STN (HCAPLUS Online) structure and text (enclosed)	11/2/2005	NG
Limited Classification (544/153) with text (EAST)	11/2/2005	NG